



WANSEMI
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WP036N10KF

Enhancement Mode N-Channel Power MOSFET

TO-263/NMOS/100V/ $\pm 20\text{V}$ /3V/120A/3.0m Ω

Rev0.5

100V, 3.0mΩ, 120A, N-Channel MOSFET

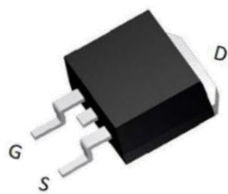
1.Features

- ◆ Low Gate Charge
- ◆ Ultra-low $R_{DS(on)}$
- ◆ 100% UIS Tested

V_{DS}	$R_{DS(on)}$ Typ.	I_D Max.
100V	3.0mΩ @ 10V	120A

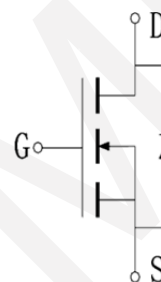
2.Applications

- ◆ Power Management in Telecom., Industrial Automation
- ◆ Motor Driving in Power Tool, E-Vehicle, Robotics
- ◆ Current switching in DC/DC & AC/DC (SR) Sub-systems



TO-263

Pin Description



Schematic Diagram

3.Package Marking and Ordering Information

Part no.	Package	Marking	PCS/Reel	PCS/CTN.
WP036N10KF	TO-263	WP036N10KF	800	4000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V_{DSS}	100	V
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	I_D	120	A
Drain Current (Pulse), $PW \leq 300\mu s$	I_{DP}	480	A
Total Dissipation	P_D	277	W
Avalanche Energy, Single Pulsed	E_{AS}	150	mJ
Junction Temperature	T_j	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Junction to Ambient	$R_{\theta JA}$	52	$^{\circ}\text{C/W}$
Junction to case	$R_{\theta JC}$	0.42	$^{\circ}\text{C/W}$

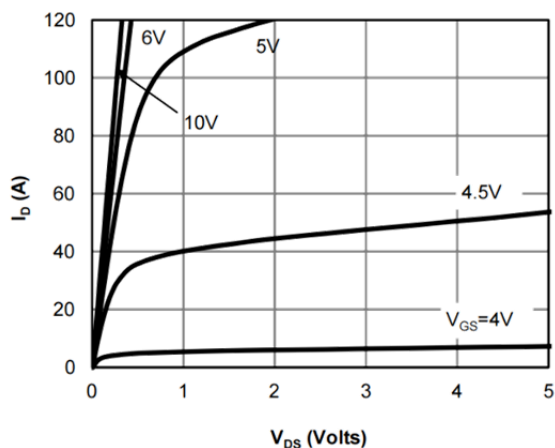
Note 2: When mounted on 1 inch square copper board $t \leq 10\text{sec}$ The value in any given application depends on the user's specific board design.

6. Electrical Characteristics at $T_a=25^{\circ}\text{C}$ (Note 3)

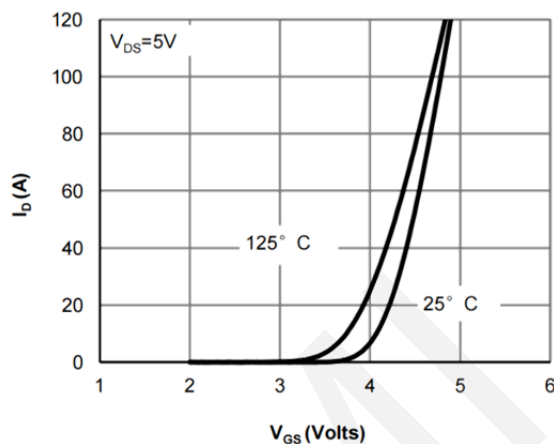
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu\text{A}$, $V_{GS} = 0\text{V}$	100	104	-	V
Zero-Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 100\text{V}$, $V_{GS} = 0\text{V}$	-	-	1	μA
Gate to Source Leakage Current	I_{GSS1}	$V_{GS} = \pm 20\text{V}$, $V_{SS} = 0\text{V}$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{DS}=250\mu\text{A}$	2.7	3.0	3.3	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = 20\text{A}$, $V_{GS} = 10\text{V}$	-	3.0	3.6	$\text{m}\Omega$
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$, Frequency=1.0MHz	-	6180	-	pF
Output Capacitance	C_{oss}		-	1660	-	pF
Reverse Transfer Capacitance	C_{rss}		-	29	-	pF
Turn-on Delay Time	$t_{d(on)}$	$V_{DS} = 50\text{V}$, $R_L=2.5\Omega$ $V_{GS} = 10\text{V}$, $R_{GEN} = 3\Omega$,	-	24	-	ns
Rise Time	t_r		-	18	-	ns
Turn-off Delay Time	$t_{d(off)}$		-	52	-	ns
Fall Time	t_f		-	22	-	ns
Total Gate Charge	Q_g	$V_{DS} = 50\text{V}$, $V_{GS} = 10\text{V}$, $I_D = 20\text{A}$	-	78	-	nC
	Q_{gs}		-	22	-	nC
	Q_{gd}		-	15	-	nC
Diode Forward Voltage	V_{FSD}	$I_S = 20\text{A}$, $V_{GS} = 0\text{V}$	0.5	-	1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

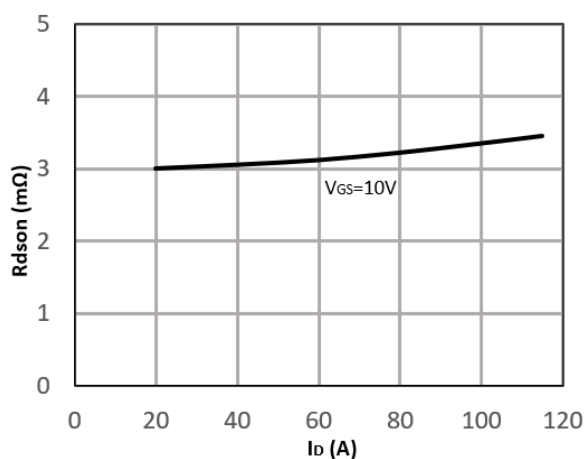
7. Typical electrical and thermal characteristics



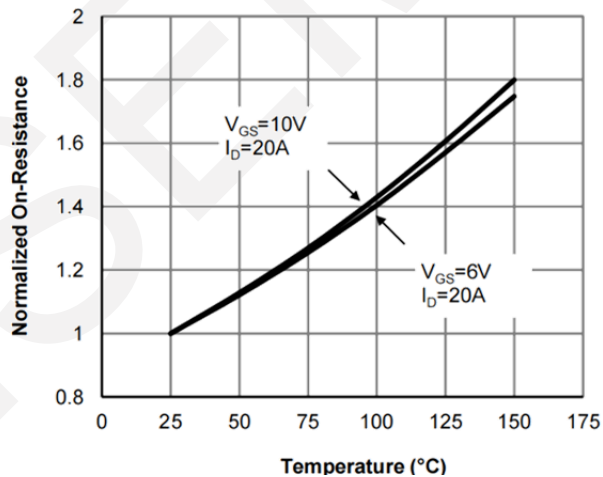
Saturation Characteristics



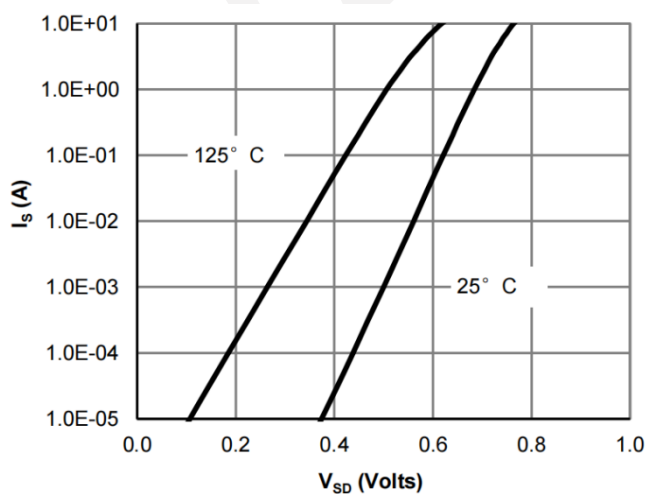
Transfer Characteristics



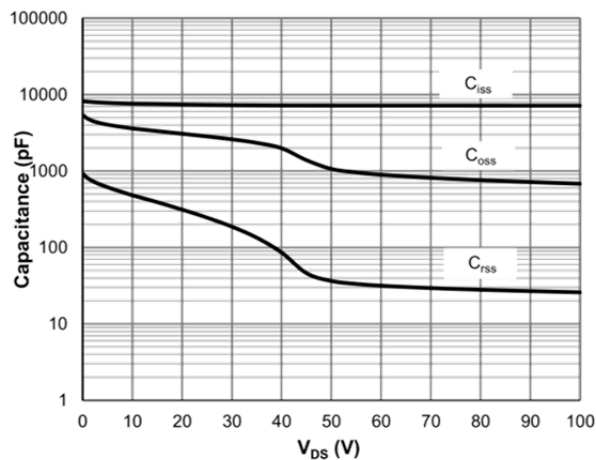
$R_{DS(ON)}$ vs. Drain Current



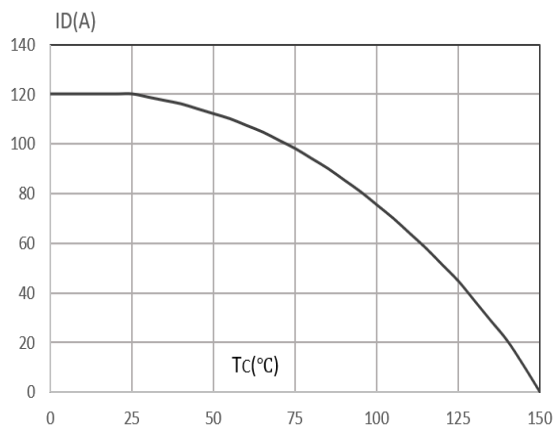
$R_{DS(ON)}$ vs. Junction Temperature



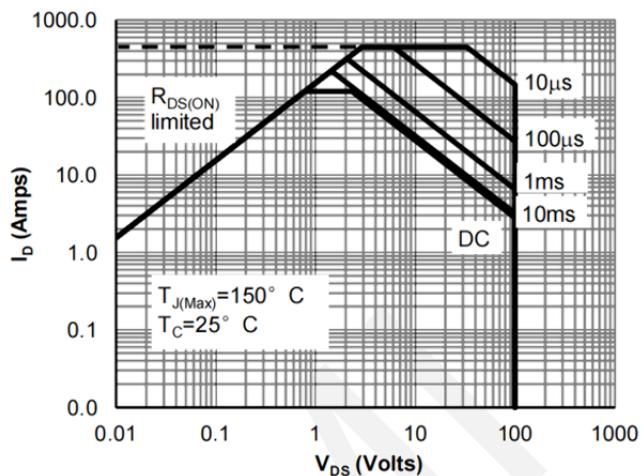
Body-diode Characteristics



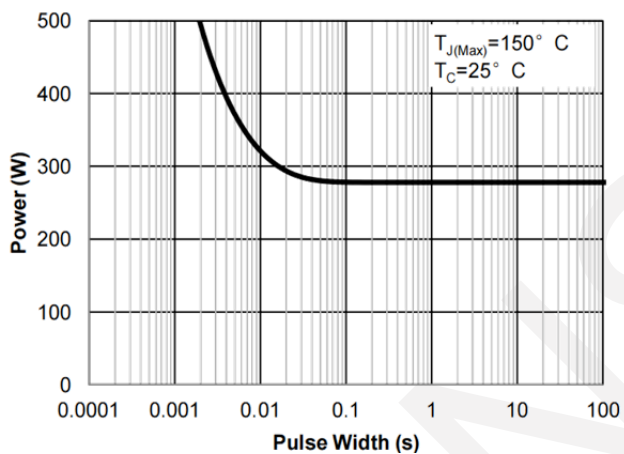
Capacitance Characteristics



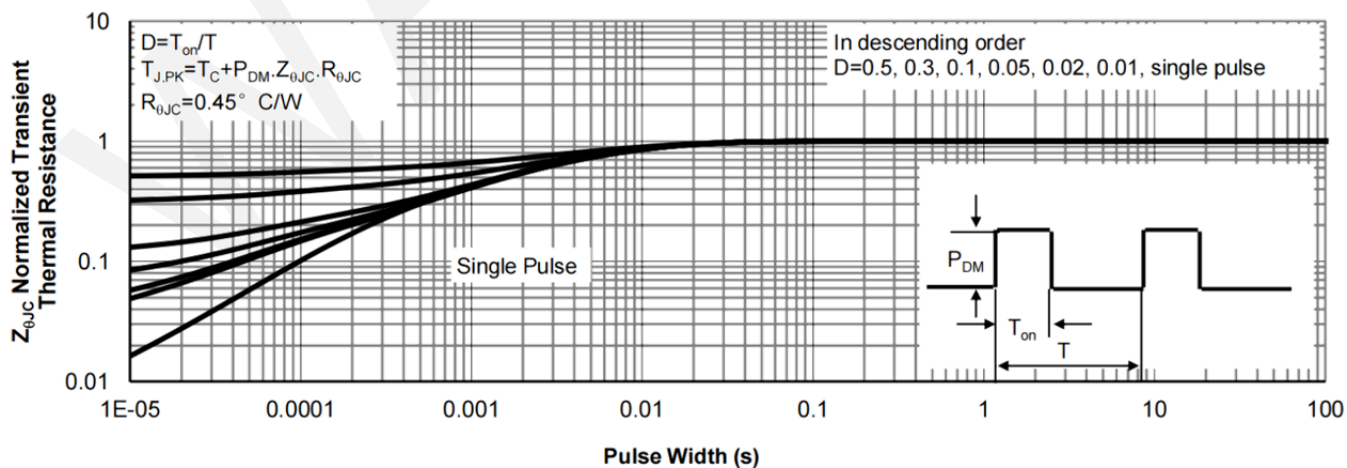
Current De-Rating



Maximum Safe Operating Area

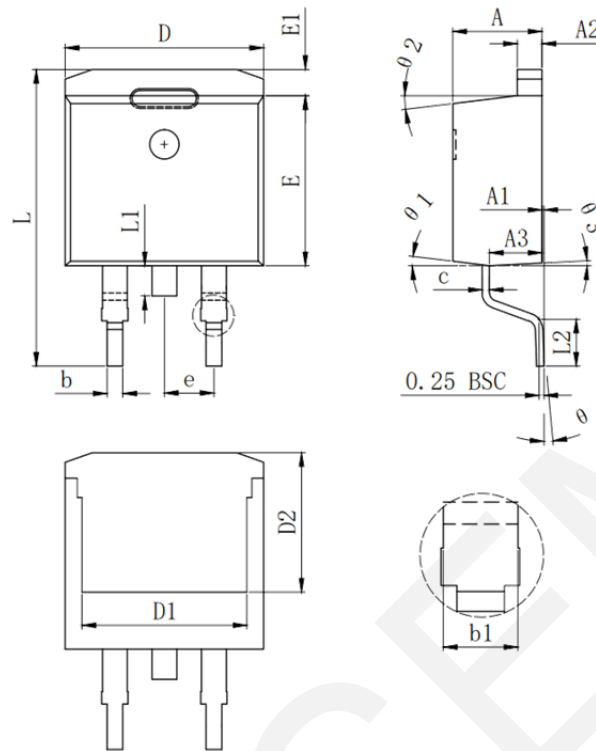


Single Pulse Power Rating, Junction-To-Case



Maximum Transient Thermal Impedance

8.Package Dimensions



SYMBOL	MILLIMETER		
	MIN	Typ.	MAX
A	4.370	4.570	4.770
A1	0.000		0.250
A2	1.220	1.270	1.420
A3	2.490	2.690	2.890
b	0.700	0.810	0.960
b1	1.170	1.270	1.470
c	0.300	0.380	0.530
D	9.860	10.160	10.360
D1	8.400 REF		
D2	7.073 REF		
E	8.500	8.700	8.900
E1	1.070	1.270	1.470
e	2.540 TYP		
L	14.700	15.100	15.500
L1	1.400	1.550	1.700
L2	2.000	2.300	2.600
θ	0°		9°
θ 1	7° TYP		
θ 2	7° TYP		
θ 3	3° TYP		

9. Important Notice

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